

**Search Notes**

Application/Control No.

10/657,434

Examiner

David Mis

Applicant(s)/Patent under  
Reexamination

JENSEN ET AL.

Art Unit

2817

**SEARCHED**

Class	Subclass	Date	Examiner
331	1A, 14, 16-18, 23, 25, Dig. 2	2/10/2005	DM
327	156-159		
332	127		
360	51		
375	376		
455	260		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR